

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned  
Examiner: To Be Assigned

In re PATENT APPLICATION of

Applicant(s) : Motoki KOBAYASHI et al.

Appln. No. : To Be Assigned

Filed : September 30, 2003

For : SEMICONDUCTOR DEVICE AND  
SEMICONDUCTOR DEVICE  
FABRICATION METHOD

Atty. Dkt. : FUJI 137

**INFORMATION  
DISCLOSURE  
STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

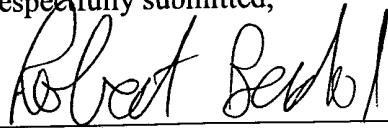
Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

Attached are copies of four Japanese patent publications. Any relevance of the publications can be gleaned from the attached English-language Abstracts. The publications are listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the documents submitted. Consideration of the submitted documents is respectfully requested.

Respectfully submitted,



Robert H. Berdo, Jr. (Reg. No. 38,075)  
RABIN & BERDO, P.C.  
CUSTOMER NO. 23995  
(202) 371-8976  
(202) 408-0924 fax

790.00  
FEE ENCLOSED:\$  
Please charge any further  
fee to our Deposit Account  
No. 18-0000

September 30, 2003  
Date

RHB:tz

<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE STATEMENT</b>				Atty Docket		Application No.			
				<b>FUJI 137</b>		<b>To Be Assigned</b>			
				Applicant					
				<b>Motoki KOBAYASHI and Fumio ICHIKAWA</b>					
				Filing Date		Group Unit			
				<b>September 30, 2003</b>		<b>To Be Assigned</b>			
<b>U.S. PATENT DOCUMENTS</b>									
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date		
	AA								
	AB								
	AC								
	AD								
	AE								
	AF								
	AG								
	AH								
	AI								
	AJ								
<b>FOREIGN PATENT DOCUMENTS</b>									
		Document Number	Date	Country	Class	Sub-Class	Translation		
	AK	2001-308667	11/02/01	Japan			Abstract		
	AL	10-135487	05/22/98	Japan			Abstract		
	AM	10-098200	04/14/98	Japan			Abstract		
	AN	09-270515	10/14/97	Japan			Abstract		
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>									
	AO								
	AP								
	AQ								
	AR								
Examiner					Date Considered				
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.									